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Substitute for form 1449A/B/PTO				Complete if Known	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use as many sheets as necessary)				Application Number	10/506,716
				Filing Date	September 7, 2004
				First Named Inventor	Peter Hoghoj
				Art Unit	2872
				Examiner Name	Not Yet Assigned
Sheet	1	of	1	Attorney Docket Number	XENOCs 3.3-001

U.S. PATENT DOCUMENTS						
Examiner Initials*	Cite No. ¹	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	
		Number-Kind Code ² (if known)				
JMC	AA	US-6,041,099-A	03-21-2000	Gutman et al.		
JMC	AB	US-6,317,483-B1	11-13-2001	Chen		
JMC	AC	US-4,562,583-A	12-31-1985	Hoover et al.		
JMC	AD	US-5,127,028-A	06-30-1992	Wittry		
JMC	AE	US-5,999,262-A	12-07-1999	Dobschal et al.		
JMC	AF	US-5,799,056-A	08-25-1998	Gutman		
JMC	AG	US-2004/0096034-A1	05-20-2004	Michaelsen et al.		

FOREIGN PATENT DOCUMENTS							
Examiner Initials*	Cite No. ¹	Foreign Patent Document		Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T ⁴
		Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)					
JMC	BA	EP-0 115 892-B1		08-15-1984	Philips NV		✓
JMC	BB	WO-02/103710-A2		12-27-2002	X-Ray Optical Systems, Inc.		✓

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. ¹ Applicant's unique citation designation number (optional). ² See Kinds Codes of USPTO Patent Documents at www.uspto.gov or MPEP 901.04. ³ Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). ⁴ For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁵ Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. ⁶ Applicant is to place a check mark here if English language Translation is attached.

NON PATENT LITERATURE DOCUMENTS			
Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²
JMC	CA	SASANUMA et al., "A point-focusing small angle x-ray scattering camera using a doubly curved monochromator of a W/Si multilayer", Rev. Sci. Instrument, Vol. 67, No. 3, pp. 688-692, March 1, 1996	
JMC	CB	NAUDON et al., "New Apparatus for Grazing Reflectometry in the Angle-Resolved Dispersive Mode", J. Appl. Cryst. Vol. 22, Part 5, pp. 460-464, October 1, 1989	

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

¹ Applicant's unique citation designation number (optional). ² Applicant is to place a check mark here if English language Translation is attached.

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Examiner Signature		Date Considered	10/25/05
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